

INFORMATION DISCLOSURE  
CITATION

ATTY. DOCKET NO.

DIVISIONAL OF SERIAL NO.

160-386

~~10/292,583~~

10 609410

APPLICANT

NAKAMURA et al

FILING DATE

GROUP

July 1, 2003

2825

## U.S. PATENT DOCUMENTS

| EXAMINER<br>INITIAL | DOCUMENT NUMBER | DATE    | NAME              | CLASS | SUBCLASS | FILING DATE<br>IF APPROPRIATE |
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\*Examiner

*Rebecca N. Proulx*

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